

Search Notes

Application/Control No.

10/796,121

Examiner

Luan K. Bui

Applicant(s)/Patent under
Reexamination

EVANS ET AL.

Art Unit

3728

SEARCHED

Class	Subclass	Date	Examiner
206	528, 530	9/15/2006	LKB
	531, 532		
	534, 538		
	539		
	469, 470		
221	25		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner